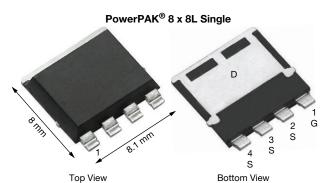
RoHS



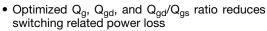
N-Channel 40 V (D-S) 175 °C MOSFET

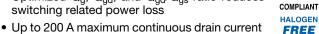


. 00	20110111 11011			
PRODUCT SUMMARY				
V _{DS} (V)	40			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.00096			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5 \text{ V}$	0.00115			
Q _g typ. (nC)	127			
I _D (A) a, g	200			
Configuration	Single			

FEATURES

- TrenchFET® Gen IV power MOSFET
- Fully lead (Pb)-free device

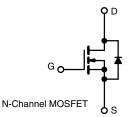




- 50 % smaller footprint than D²PAK / TO-263
- 100 % R_a and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- · Synchronous rectification
- OR-ing
- Motor drive control
- · Battery management



ORDERING INFORMATION				
Package	PowerPAK 8 x 8L			
Lead (Pb)-free and halogen-free	SiJH440E-T1-GE3			
APSOLUTE MAYIMUM DATINGS (T 25 °C. uplace otherwise noted)				

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	40	V	
Gate-source voltage		V _{GS}	+20 / -16	V	
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		200 ^a		
	T _C = 70 °C		200 ^a		
	T _A = 25 °C	I _D	40 b		
	T _A = 70 °C	1	33.8 b		
Pulsed drain current (t = 100 μs)		I _{DM}	500	A	
Continuous source-drain diode current	T _C = 25 °C		160		
	T _A = 25 °C	I _S	2.67 ^{b, c}		
Single pulse avalanche current	. 0.1	I _{AS}	60		
Single pulse avalanche energy	L = 0.1 mH	E _{AS}	180	mJ	
Maximum power dissipation	T _C = 25 °C		158		
	T _C = 70 °C		110	10/	
	T _A = 25 °C	P _D	3 b	W	
	T _A =70 °C	†	2.1 ^b		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +175	20	
Soldering recommendations (peak temperature) c			260	°C	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient ^b	Steady state	R _{thJA}	42	50	°C/W	
Maximum junction-to-case (drain)	Steady state	R_{thJC}	0.8	0.95	7 0/00	

Notes

- Package limited.
- Surface mounted on 1" x 1" FR4 board.
- See solder profile (www.vishay.com/doc?73257). The PowerPAK 8 x 8L is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components. Maximum under steady state conditions is 50 °C/W.
- $T_C = 25$ °C.



Vishay Siliconix

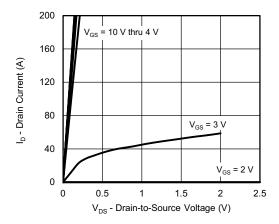
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	40	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = 10 mA	-	24	-	m\//°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-6.6	-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1	-	2.3	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +20 \text{ / } -16 \text{ V}$	-	-	100	nA	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 40 V, V _{GS} =0 V	-	-	1		
		V _{DS} = 40 V, V _{GS} = 0 V, T _J = 70 °C	-	-	15	μA	
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	60	-	-	Α	
Drain-source on-state resistance ^a	_	V _{GS} = 10 V, I _D = 20 A	-	0.00080	0.00096	Ω	
	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$	-	0.00096	0.00115		
Forward transconductance a	9 _{fs}	$V_{DS} = 15 \text{ V}, I_D = 20 \text{ A}$	-	140	-	S	
Dynamic ^b						•	
Input capacitance	C _{iss}	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz	-	20 330	-	pF	
Output capacitance	C _{oss}		-	2920	-		
Reverse transfer capacitance	C _{rss}		-	820	-		
	0	$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	279	420	nC	
Total gate charge	Q_g		-	127	195		
Gate-source charge	Q _{gs}	V_{DS} = 20 V, V_{GS} = 4.5 V, I_D =20 A	-	64	-		
Gate-drain charge	Q _{gd}		-	24.5	-		
Gate resistance	R_{g}	f = 1 MHz	0.5	1.7	3.0	Ω	
Turn-on delay time	t _{d(on)}	$V_{DD} = 20 \text{ V}, R_L = 10 \Omega, I_D \cong 20 \text{ A},$	-	28	56		
Rise time	t _r		-	35	70		
Turn-off delay time	t _{d(off)}	$V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	105	210	1	
Fall time	t _f		-	30	60	1	
Turn-on delay time	t _{d(on)}		-	140	280	ns	
Rise time	t _r	$\begin{split} V_{DD} = 20 \ V, \ R_L = 1 \ \Omega, \ I_D &\cong 20 \ A, \\ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega \end{split}$	-	290	580		
Turn-off delay time	t _{d(off)}		-	78	156		
Fall time	t _f		-	53	106		
Drain-Source Body Diode Characteristi	cs						
Continuous source-drain diode current	IS	T _C = 25 °C	-	-	160		
Pulse diode forward current	I _{SM}		-	-	300	A	
Body diode voltage	V_{SD}	I _S = 5 A, V _{GS} = 0 V	-	0.68	1.1	V	
Body diode reverse recovery time	t _{rr}		-	92	184	ns	
Body diode reverse recovery charge	Q_{rr}		-	245	490	nC	
Reverse recovery fall time	ta	$I_F = 20 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$	-	54	-	ns	
Reverse recovery rise time	t _b		-	38	-		

Notes

- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

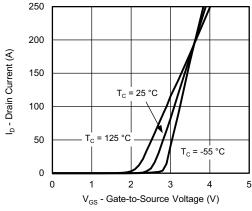
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



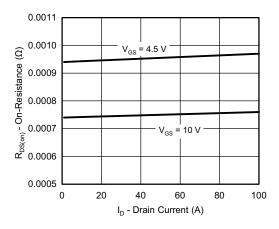


Output Characteristics

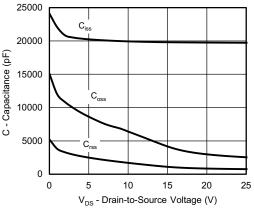




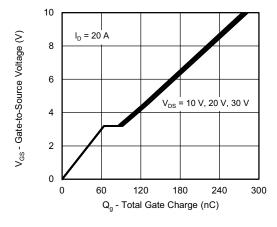
Transfer Characteristics



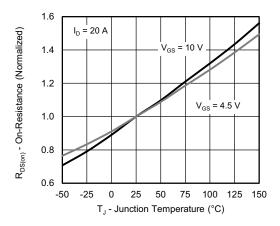
On-Resistance vs. Drain Current and Gate Voltage



Capacitance

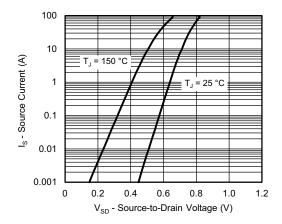


Gate Charge

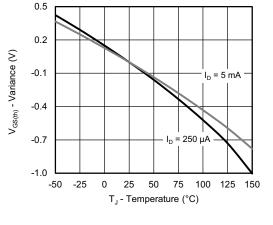


On-Resistance vs. Junction Temperature

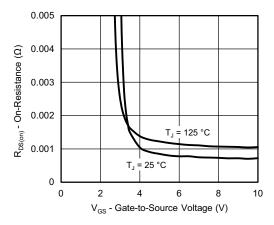




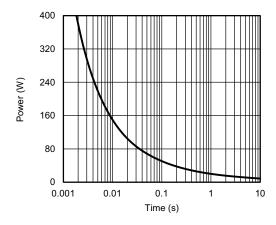
Source-Drain Diode Forward Voltage



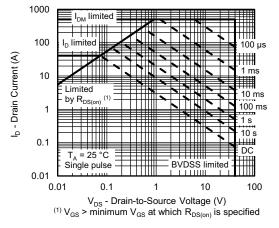
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

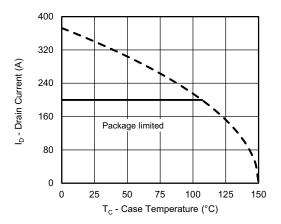


Single Pulse Power, Junction-to-Ambient

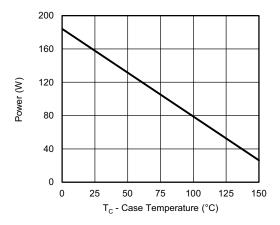


Safe Operating Area, Junction-to-Ambient

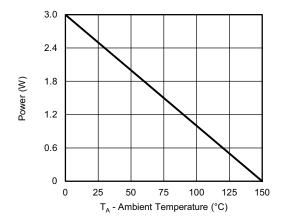




Current Derating a





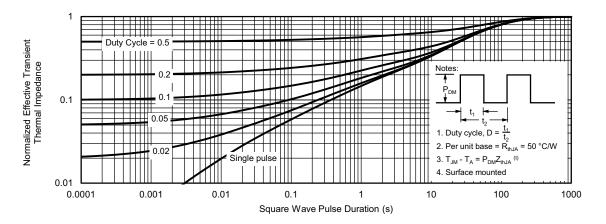


Power, Junction-to-Ambient

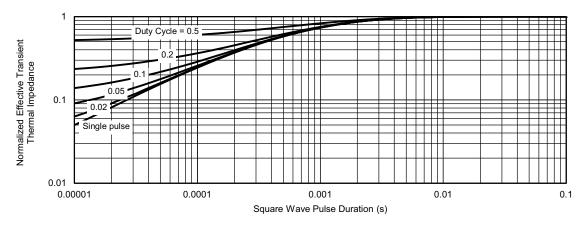
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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